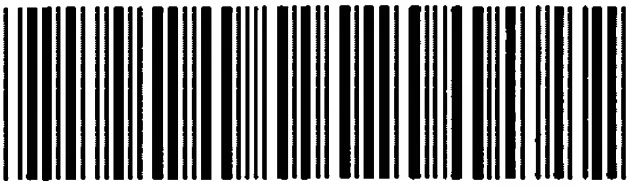


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/644,561	PAO ET AL.	
	Examiner	Art Unit	
	Erin M. File	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	298	4/21/2006	EMF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	4/21/2006	EMF